

REVISIONS														
LTR	DESCRIPTION	DATE	APPROVED											
D	Change max frequency $C_L = 15$ pF subgroups 10 and 11. Change max frequency $C_L = 50$ pF subgroups 10 and 11. Change code ident. no. to 67268. Change to military drawing format. Add CAGE 01295 for case outline S and 2.	6 NOV. 1987	<i>RPEvans</i>											

CURRENT CAGE CODE 67268

REV														
PAGE														
REV STATUS OF PAGES	REV	D	D	D	D	D	D	D	D	D	D	D	D	
	PAGES	1	2	3	4	5	6	7	8	9	10	11		

Defense Electronics Supply Center Dayton, Ohio Original date of drawing: 7 December 1978 AMSC N/A	PREPARED BY <i>Joseph R. Kirby</i>	MILITARY DRAWING This drawing is available for use by all Departments and Agencies of the Department of Defense TITLE: MICROCIRCUIT, DIGITAL, LOW POWER SCHOTTKY TTL, OCTAL D-TYPE FLIP FLOP WITH CLEAR, MONOLITHIC SILICON DWG NO. 78010
	CHECKED BY <i>DA DiCenzo</i>	
	APPROVED BY <i>Robert P. Evans</i>	
	SIZE CODE IDENT. NO. A 14933	
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5962-E590

DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

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MAY 88

1. SCOPE

1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:

78010	01	R	X
Drawing number	Device type (1.2.1)	Case outline (1.2.2)	Lead finish per MIL-M-38510

1.2.1 Device type. The device type shall identify the circuit function as follows:

Device type	Generic number	Circuit function
01	54LS273	Octal D-type, flip flop with clear

1.2.2 Case outlines. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

Outline letter	Case outline
R	D-8 (20-lead, 1/4" x 1 1/16"), dual-in-line package
S	F-9 (20-lead, 1/4" x 1/2"), flat package
2	C-2 (20-terminal, .350" x .350"), square chip carrier package

1.3 Absolute maximum ratings.

Supply voltage range	-0.5 V dc to +7.0 V dc
Input voltage range	-1.5 V dc at -18 mA to +5.5 V dc
Storage temperature	-65°C to +150°C
Maximum power dissipation (P_D) 1/	19 mW
Lead temperature (soldering, 10 seconds)	+300°C
Thermal resistance, junction-to-case (θ_{JC})	See MIL-M-38510, appendix C
Junction temperature (T_J)	+175°C

1.4 Recommended operating conditions.

Supply voltage (V_{CC})	+4.5 V dc minimum to +5.5 V dc maximum
Minimum high level input voltage (V_{IH})	2.0 V dc
Maximum low level input voltage (V_{IL})	0.7 V dc
Case operating temperature range (T_C)	-55°C to +125°C
Clock frequency, (F clock)	0 to 30 MHz
High level output current, (I_{OH})	-400 μ A maximum
Low level output current, (I_{OL})	4 mA maximum
Width of clock or clear pulse (t_w)	30 ns minimum
Setup time (t_{su})	
Data input	20 ns minimum
Clear to inactive state	25 ns minimum
Data hold time (t_h)	5 ns minimum

1/ Must withstand the added P_D due to short circuit test (e.g., I_{OS}).

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2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.

3.2.2 Truth table. The truth table shall be as specified on figure 2.

3.2.3 Logic diagram. The logic diagram shall be as specified on figure 3.

3.2.4 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.

3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table 1 and apply over the full recommended case operating temperature range.

3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

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TABLE 1. Electrical performance characteristics.

Test	Symbol	Conditions $-55^{\circ}\text{C} \leq T_C \leq +125^{\circ}\text{C}$, unless otherwise specified	Group A subgroups	Limits		Unit
				Min	Max	
High level output voltage	V_{OH}	$V_{CC} = 4.5\text{ V};$ $I_{OH} = -400\text{ }\mu\text{A}$ $V_{IN} = 0.7\text{ V or }2.0\text{ V}$	1, 2, 3	2.5		V
Low level output voltage	V_{OL}	$V_{CC} = 4.5\text{ V};$ $I_{OL} = 4\text{ mA}$ $V_{IN} = 0.7\text{ V or }2.0\text{ V}$	1, 2, 3		0.4	V
Input clamp voltage	V_{IC}	$V_{CC} = 4.5\text{ V};$ $T_C = +25^{\circ}\text{C}$ $I_{IN} = -18\text{ mA};$	1		-1.5	V
High level input current	I_{IH1}	$V_{CC} = 5.5\text{ V};$ $V_{IN} = 5.5\text{ V}$	1, 2, 3		0.1	mA
	I_{IH2}	$V_{CC} = 5.5\text{ V};$ $V_{IN} = 2.7\text{ V}$	1, 2, 3		20	μA
Low level input current	I_{IL}	$V_{CC} = 5.5\text{ V};$ $V_{IN} = 0.4\text{ V}$	1, 2, 3		-0.4	mA
Short circuit output current	I_{OS}	$V_{CC} = 5.5\text{ V } \underline{1/}$	1, 2, 3	-15	-130	mA
Supply current	I_{CC}	$V_{CC} = 5.5\text{ V } \underline{2/}$	1, 2, 3		27	mA
Functional tests		See 4.4.1c	7			
Maximum clock frequency <u>3/</u>	F_{MAX}	$V_{CC} = 5.0\text{ V}$ $R_L = 2\text{ k}\Omega \pm 5\%$	$C_L = 15\text{ pF } \pm 10\%$	9	30	MHz
				10, 11	18	MHz
			$C_L = 50\text{ pF } \pm 10\%$	9	24	MHz
				10, 11	17	MHz

See footnotes at end of table.

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TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions -55°C < T _C < +125°C, unless otherwise specified		Group A subgroups	Limits		Unit	
					Min	Max		
Propagation delay time, high to low, clear to output <u>3/</u>	t _{PHL1}	V _{CC} = 5.0 V R _L = 2 kΩ ±5%	C _L = 15 pF ±10%	9		27	ns	
				10, 11		38	ns	
			C _L = 50 pF ±10%	9		32	ns	
				10, 11		42	ns	
Propagation delay time, low to high, clock to output <u>3/</u>	t _{PLH}		C _L = 15 pF ±10%	C _L = 15 pF ±10%	9		27	ns
					10, 11		38	ns
				C _L = 50 pF ±10%	9		32	ns
					10, 11		42	ns
Propagation delay time, high to low, clock to output <u>3/</u>	t _{PHL2}	C _L = 15 pF ±10%		C _L = 15 pF ±10%	9		27	ns
					10, 11		38	ns
				C _L = 50 pF ±10%	9		32	ns
					10, 11		42	ns

1/ Not more than one output should be shorted at a time, and the duration of the short circuit condition should not exceed 1 second.

2/ With all outputs open and 4.5 V applied to all data and clear inputs, I_{CC} is measured after a momentary ground, then 4.5 V is applied to clock.

3/ Propagation delay time and maximum clock frequency testing may be performed using either C_L = 15 pF or C_L = 50 pF. However, the manufacturer must certify and guarantee that the microcircuits meet the test limits specified for a 50 pF load.

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3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

a. Burn-in test (method 1015 of MIL-STD-883).

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

(2) $T_A = +125^{\circ}\text{C}$, minimum.

b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

a. Tests shall be as specified in table II herein.

b. Subgroups 4, 5, 6, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.

c. Subgroup 7 tests shall verify the truth table.

4.3.2 Groups C and D inspections.

a. End-point electrical parameters shall be as specified in table II herein.

b. Steady-state life test (method 1005 of MIL-STD-883) conditions:

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

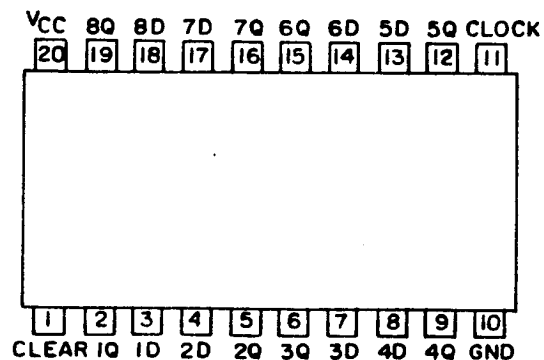
(2) $T_A = +125^{\circ}\text{C}$, minimum.

(3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

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Cases R and S



Case 2

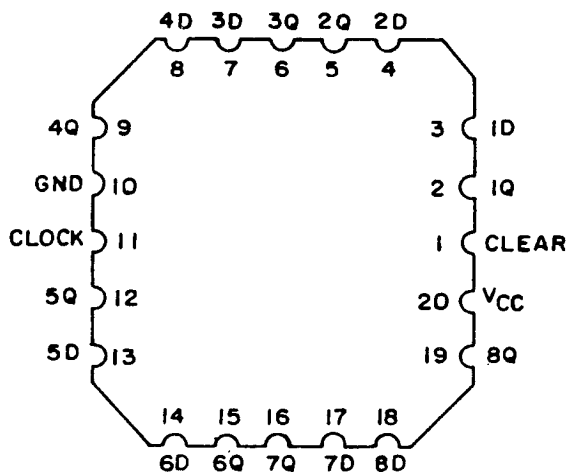


FIGURE 1. Terminal connections (top view) and logic diagram.

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(Each flip flop)

Inputs			Output
Clear clock D			Q
L	X	X	L
H	↑	H	H
H	↑	L	L
H	L	X	Q ₀

H = High level (steady state)
 L = Low level (steady state)
 X = Don't care
 ↑ = Low to high transition
 Q₀ = The level of Q before the indicated steady state input conditions were established

FIGURE 2. Truth table.

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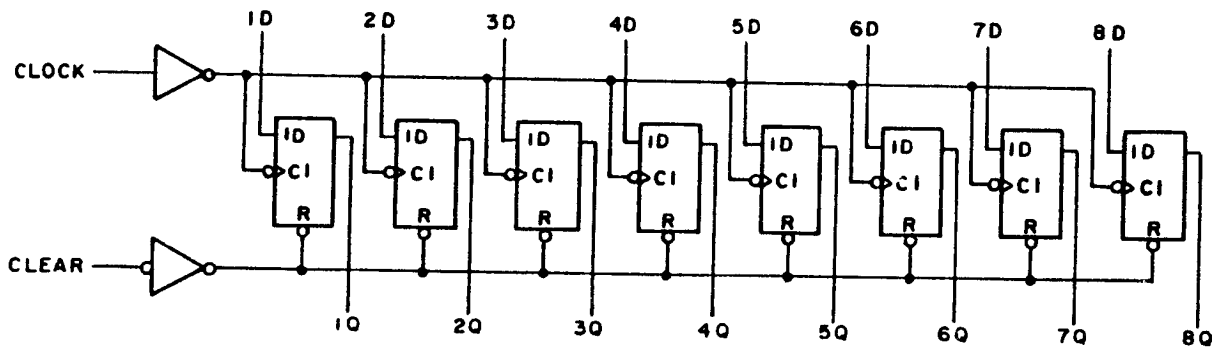


FIGURE 3. Logic diagram.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	---
Final electrical test parameters (method 5004)	1*, 2, 3, 9
Group A test requirements (method 5005)	1, 2, 3, 7, 9 10, 11
Groups C and D end point electrical parameters (method 5005)	1, 2, 3

* PDA applies to subgroup 1.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 Replaceability. Replaceability is determined as follows:

- Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/32501B--.

6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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6.4 Approved sources of supply. Approved sources of supply are listed herein. Additional sources will be added as they become available. The vendors listed herein have agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor 2/ similar part number	Replacement military specification part number
7801001RX <u>1/</u>	18324 04713 01295	54LS273/BRA 54LS273/BRAJC SNJ54LS273J	M38510/32501BRX
7801001SX <u>1/</u>	18324 04713 01295	54LS273/BSA 54LS273/BSAJC SNJ54LS273W	M38510/32501BSX
78010012X <u>1/</u>	18324 04713 01295	54LS273/B2X 54LS273M/B2CJC SNJ54LS273FK	M38510/32501B2X

1/ Inactive for new design; use QPL-38510 product.

Z/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE
number

Vendor name
and address

18324

Signetics Corporation
4130 South Market Court
Sacramento, CA 95834

04713

Motorola, Incorporated
7402 S. Price Road
Tempe, AZ 85283

01295

Texas Instruments, Incorporated
P.O. Box 6448
Midland, TX 79701

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